

Dual N-channel 30 V, 5.1 mΩ standard level MOSFET

6 November 2013

Product data sheet

1. General description

Dual standard level N-channel MOSFET in an LFPAK56D (Dual Power-SO8) package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

2. Features and benefits

- Dual MOSFET
- Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True standard level gate with $V_{GS(th)}$ of greater than 1 V at 175 $^\circ\text{C}$

3. Applications

- 12 V Automotive systems
- Motors, lamps and solenoid control
- Transmission control
- Ultra high performance power switching

4. Quick reference data

Table 1. Q	uick reference data					
Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	30	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 1</u>	-	-	40	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>	-	-	68	W
Static chara	cteristics FET1 and FET2					
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 10 A; T _j = 25 °C; <u>Fig. 12</u>	-	4.34	5.1	mΩ
Dynamic ch	aracteristics FET1 and FE	T2				
Q _{GD}	gate-drain charge	$I_{D} = 10 \text{ A}; V_{DS} = 24 \text{ V}; V_{GS} = 10 \text{ V};$ $T_{j} = 25 \text{ °C}; \underline{\text{Fig. 14}}; \underline{\text{Fig. 15}}$	-	9	-	nC





Dual N-channel 30 V, 5.1 m Ω standard level MOSFET

5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source1	8 7 6 5	D1 D1 D2 D2
2	G1	gate1		
3	S2	source2	\bigcirc	
4	G2	gate2		
5	D2	drain2		 S1 G1 S2 G2
6	D2	drain2		mbk725
7	D1	drain1	1 2 3 4 LFPAK56D (SOT1205)	
8	D1	drain1	(0011200)	

6. Ordering information

Table 3. Ordering information						
Type number	Package	ge				
	Name	Description	Version			
BUK7K5R1-30E	LFPAK56D	Plastic single ended surface mounted package (LFPAK56D); 8 leads	SOT1205			

7. Marking

Table 4. Marking codes	
Type number	Marking code
BUK7K5R1-30E	75E130

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	30	V
V _{DGR}	drain-gate voltage	R_{GS} = 20 k Ω ; $T_j \ge 25 \text{ °C}$; $T_j \le 175 \text{ °C}$	-	30	V
V _{GS}	gate-source voltage	T _j ≤ 175 °C; DC	-20	20	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; <u>Fig. 1</u>	-	40	А
		T _{mb} = 100 °C; V _{GS} = 10 V; <u>Fig. 1</u>	-	40	А
I _{DM}	peak drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \ \mu$ s; Fig. 4	-	340	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>	-	68	W
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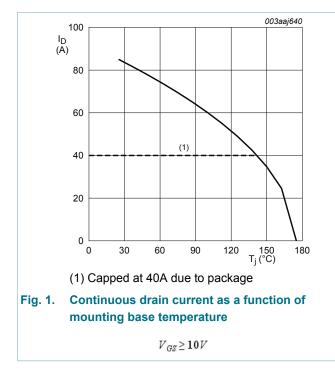
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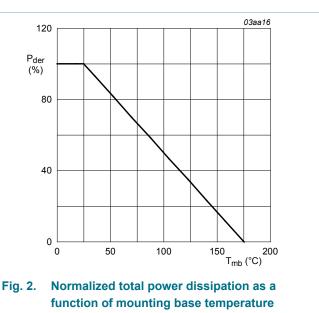
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Symbol	Parameter	Conditions		Min	Мах	Unit
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
$T_{sld(M)}$	peak soldering temperature			-	260	°C
Source-drain	diode FET1 and FET2			1	1	
I _S	source current	T _{mb} = 25 °C		-	40	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^\circ C$		-	340	А
Avalanche Ru	iggedness FET1 and FET2					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_{D} &= 40 \text{ A}; \text{V}_{sup} \leq 30 \text{V}; \text{V}_{GS} = 10 \text{V}; \\ \text{T}_{j(\text{init})} &= 25 ^{\circ}\text{C}; \underline{\text{Fig. } 3} \end{split}$	[<u>1][2]</u>	-	228	mJ

[1] Refer to application note AN10273 for further information

[2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C

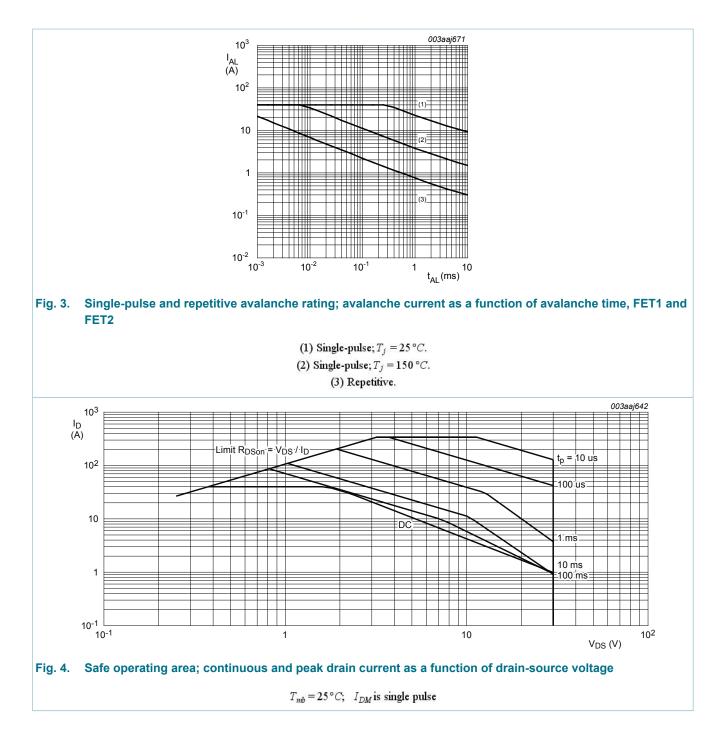




$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

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Dual N-channel 30 V, 5.1 mΩ standard level MOSFET



9. Thermal characteristics

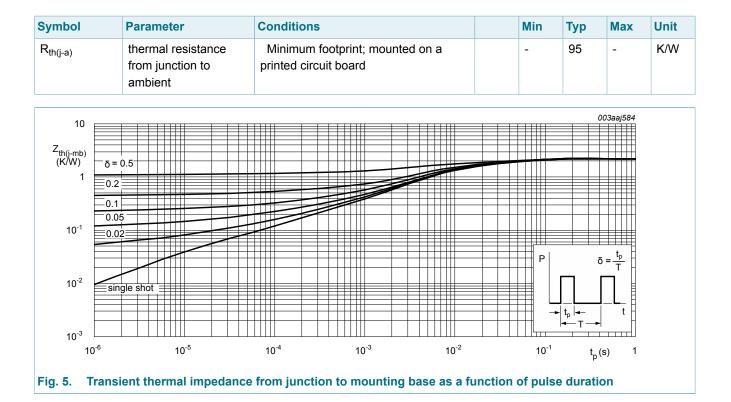
Table 6. The	rmal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. <u>5</u>	-	-	2.21	K/W

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Dual N-channel 30 V, 5.1 m Ω standard level MOSFET



10. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics FET1 and FET2	· · · · · · · · · · · · · · · · · · ·				
V _{(BR)DSS}	drain-source	I_D = 250 µA; V_{GS} = 0 V; T_j = -55 °C	27	-	-	V
	breakdown voltage	I_D = 250 µA; V_{GS} = 0 V; T_j = 25 °C	30	-	-	V
	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ Fig. 10; Fig. 11	2.4	3	4	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 175 °C; Fig. 10; Fig. 11	1	-	-	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; Fig. 10; Fig. 11	-	-	4.5	V
I _{DSS}	drain leakage current	V_{DS} = 30 V; V_{GS} = 0 V; T_j = 175 °C	-	-	500	μA
		V_{DS} = 30 V; V_{GS} = 0 V; T_j = 25 °C	-	0.02	1	μA
I _{GSS}	gate leakage current	V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
		V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 10 A; T _j = 25 °C; Fig. 12	-	4.34	5.1	mΩ
		V _{GS} = 10 V; I _D = 10 A; T _j = 175 °C; Fig. 12; Fig. 13	-	7.6	9.4	mΩ

BUK7K5R1-30E

Dual N-channel 30 V, 5.1 m Ω standard level MOSFET

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Dynamic cl	naracteristics FET1 and FE	ET2	I			
Q _{G(tot)}	total gate charge	I_D = 10 A; V_{DS} = 24 V; V_{GS} = 10 V;	-	31.1	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C; <u>Fig. 14; Fig. 15</u>	-	7.6	-	nC
Q _{GD}	gate-drain charge		-	9	-	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz; T _j = 25 °C; <u>Fig. 16</u>	-	1764	2352	pF
C _{oss}	output capacitance		-	422	506	pF
C _{rss}	reverse transfer capacitance		-	242	332	pF
t _{d(on)}	turn-on delay time	$\begin{split} V_{DS} &= 24 \text{ V}; \text{ R}_{L} = 2.4 \Omega; \text{ V}_{GS} = 10 \text{ V}; \\ \text{R}_{G(ext)} &= 5 \Omega; \text{ T}_{j} = 25 ^{\circ}\text{C}; \text{ I}_{D} = 10 \text{ A} \end{split}$	-	9.5	-	ns
t _r	rise time		-	12.5	-	ns
t _{d(off)}	turn-off delay time		-	19.5	-	ns
t _f	fall time	-	-	13	-	ns
Source-dra	in diode FET1 and FET2		I			
V _{SD}	source-drain voltage	$I_{\rm S}$ = 10 A; $V_{\rm GS}$ = 0 V; $T_{\rm j}$ = 25 °C; Fig. 17	-	0.78	1.2	V
t _{rr}	reverse recovery time	I_{S} = 10 A; d I_{S} /dt = -100 A/µs; V_{GS} = 0 V;	-	27.4	-	ns
Q _r	recovered charge	V _{DS} = 15 V; T _j = 25 °C	-	20.7	-	nC

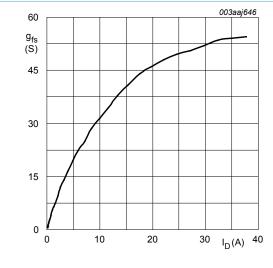
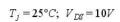


Fig. 6. Forward transconductance as a function of drain current; typical values



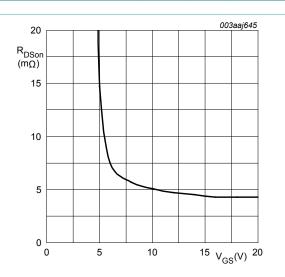
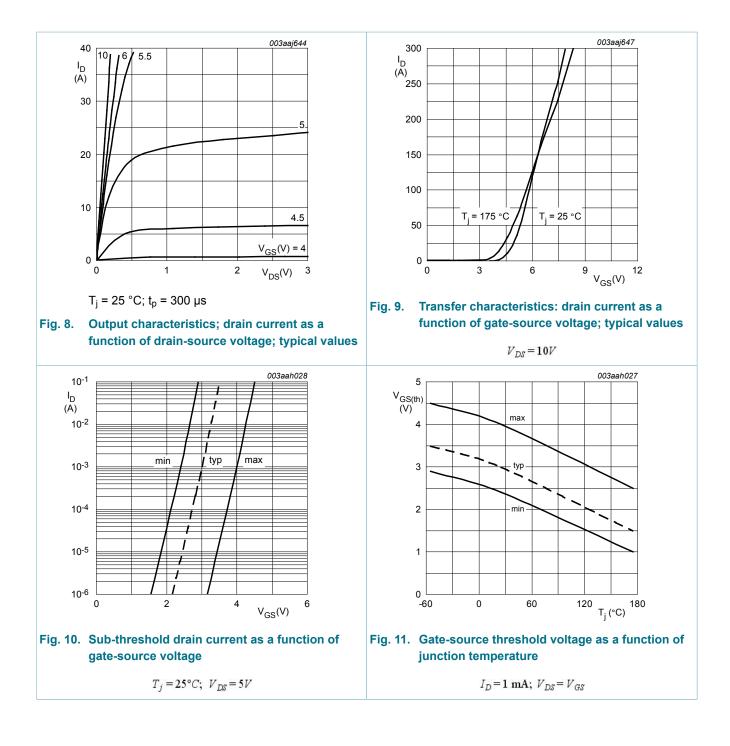


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

 $T_j = 25^{\circ}C; I_D = 10A$

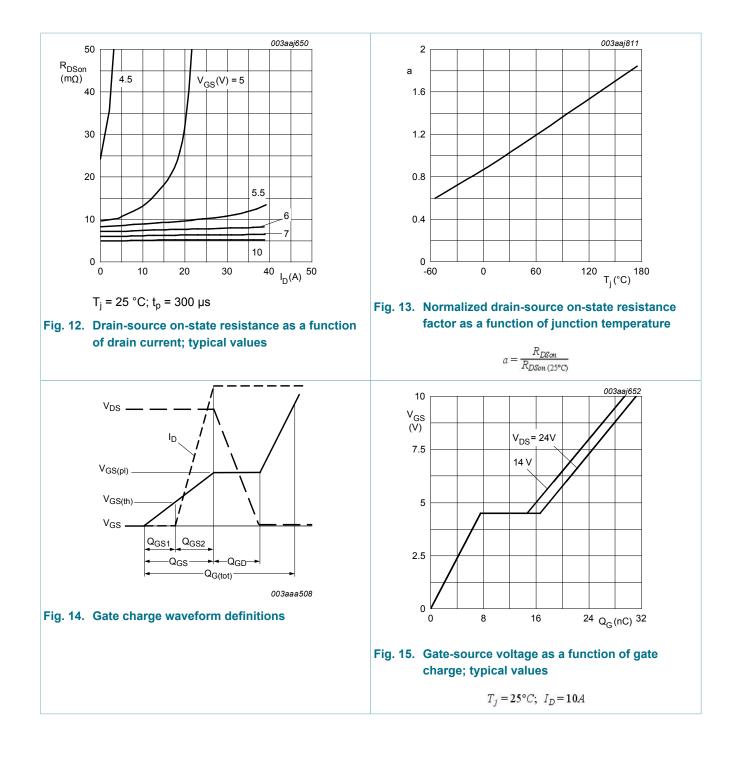
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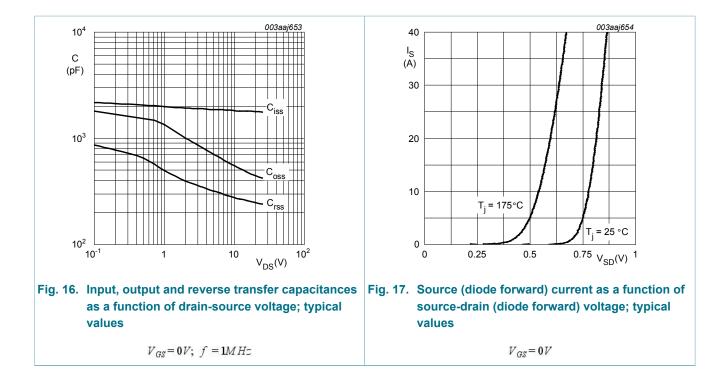
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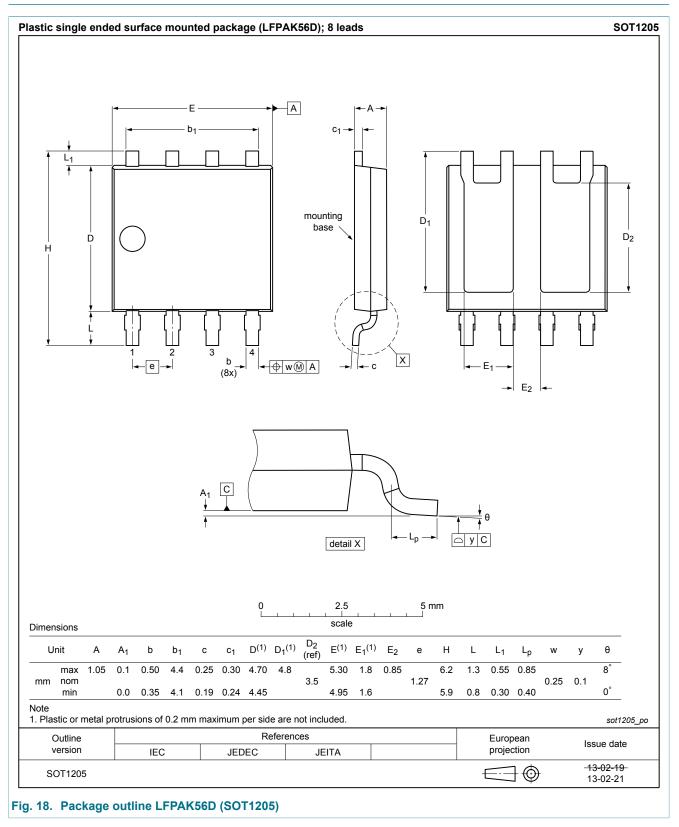


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11. Package outline



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Product data sheet

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12. Legal information

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Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Dual N-channel 30 V, 5.1 m Ω standard level MOSFET

13. Contents

1	General description	1
2	Features and benefits	1
3	Applications	1
4	Quick reference data	1
5	Pinning information	2
6	Ordering information	2
7	Marking	2
8	Limiting values	2
9	Thermal characteristics	4
10	Characteristics	5
11	Package outline	10
12	Legal information	11
12.1	Data sheet status	11
12.2	Definitions	11
12.3	Disclaimers	11
12.4	Trademarks	12

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